



SFH6325/6

High-Speed Dual Optocoupler

Preliminary

FEATURES

- Isolation Test Voltage: 5300 V_{RMS}
- TTL Compatible
- Bit Rates: 1.0 MBit/s
- High Common-Mode Transient Immunity
- Bandwidth 2.0 MHz
- Open-Collector Output
- Field-Effect Stable by TRIOS
- Underwriters Lab File #E52744

Description

The SFH6325/6326 are dual channel optocouplers with a GaAlAs infrared emitting diode, optically coupled with an integrated photodetector which consists of a photodiode and a high-speed transistor in a DIP-8 plastic package.

Signals can be transmitted between two electrically separated circuits up to frequencies of 2.0 MHz. The potential difference between the circuits to be coupled is not allowed to exceed the maximum permissible reference voltages.

Maximum Ratings T_A=25°C

Emitter (each channel)

Reverse Voltage 4.5 V
Continuous Forward Current 25 mA
Peak Forward Current
(t=1 ms, duty cycle 50%) 50 mA
Maximum Surge Forward Current
(t≤1 μs, 300 pulses/s) 1.0 A

Derate Linearly from 25°C 0.6 mW/°C
Total Power Dissipation (T_A≤70°C) 45 mW

Detector (each channel)

Supply Voltage -0.5 to 15 V
Output Voltage -0.5 to 15 V
Collector Output Current 8.0 mA
Derate Linearly from 25°C 1.33 mW/°C
Total Power Dissipation (T_A≤70°C) 100 mW

Package

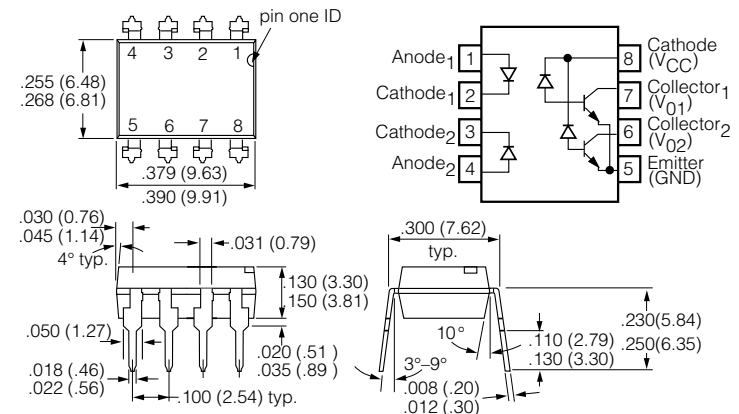
Isolation Test Voltage (t=1 sec.) 5300 V_{RMS}
Pollution Degree (DIN VDE 0109) 2
Creepage ≥7.0 mm
Clearance ≥7.0 mm
Derate Linearly from 25°C 1.93 mW/°C
Total Package Dissipation at 25°C T_A 145 mW

Comparative Tracking Index per
DIN IEC112/VDE 0303 part 1,
Group IIIa per DIN VDE 6110 175

Isolation Resistance
V_{IO}=500 V, T_A=25°C ≥10¹² Ω
V_{IO}=500 V, T_A=100°C ≥10¹¹ Ω
Storage Temperature Range -55°C to +125°C
Ambient Temperature Range ... -55°C to +100°C
Soldering Temperature

(max. 10 s, DIP soldering:
distance to seating plane ≥1.5 mm) 260°C

Dimensions in inches (mm)



Characteristics (T_A=0–70°C unless otherwise specified)

Parameter	Sym.	Min.	Typ.	Max.	Unit	Condition
Emitter						
Forward Voltage	V _F	—	1.6	1.9	V	I _F =16 mA, T _A =25°C
Breakdown Voltage	V _{BR}	4.5	—	—	V	I _R =10 μA
Reverse Current	I _R	—	0.5	10	μA	V _R =4.5 V
Capacitance	C _O	—	125	—	pF	V _R =0 V, f=1.0 MHz
Temperature Coefficient of Forward Voltage	ΔV _F /ΔT _A	—	-1.7	—	mV/°C	I _F =16 mA
Detector						
Supply Current Logic Low	I _{CCL}	—	150	400	μA	I _F =16 mA, V _O =open, V _{CC} =4.5 V
Supply Current Logic High	I _{CCH}	—	0.01	4.0	μA	I _F =0 mA, V _O =open, V _{CC} =15 V
Logic Low Output Voltage						
SFH6325	V _{OL}	—	0.1	0.5	V	I _F =16 mA, V _{CC} =4.5 V, I _O =1.1 mA, T _A =25°C
SFH6326						I _F =16 mA, V _{CC} =4.5 V, I _O =3.0 mA, T _A =25°C
Logic High Output Current	I _{OH}	—	3.0	500	nA	I _F =0 mA, T _A =25°C, V _O =V _{CC} =5.5 V
		—	—	50	μA	I _F =0 mA, V _O =V _{CC} =15 V
Channel to channel ⁽¹⁾ Crosstalk	I _{OH-XT}	—	—	500	nA	I _F =16 mA, T _A =25°C, V _O =V _{CC} =5.5 V
Package						
Coupling Capacitance Input-Output	C _{IO}	—	0.6	—	pF	f=1.0 MHz
Current Transfer Ratio						
SFH6325	CTR	7.0	16	—	%	I _F =16 mA, V _{CC} =4.5 V, V _O =0.4 V, T _A =25°C
SFH6326		19	35	—	%	
SFH6325	CTR	5.0	—	—	%	I _F =16 mA, V _{CC} =4.5 V, V _O =0.5 V
SFH6326		15	—	—	%	

Note: 1. To measure crosstalk, turn on the LED for channel 1 and measure the output current for channel 2 in logic high. Repeat for channel 2.

Switching Delay Time Characteristics

$I_F=16\text{ mA}$, $V_{CC}=5.0\text{ V}$, $T_A=25^\circ\text{C}$

Parameter	Sym.	Min.	Typ.	Max.	Unit	Condition
High-Low						
SFH6325	t_{PHL}	—	0.3	1.5	μs	$R_L=4.1\text{ k}\Omega$
SFH6326			0.2	0.8		$R_L=1.9\text{ k}\Omega$
Low-High						
SFH6325	t_{PLH}	—	0.6	1.5	μs	$R_L=4.1\text{ k}\Omega$
SFH6326			0.5	0.8		$R_L=1.9\text{ k}\Omega$

Common-Mode Transient Immunity

$V_{CM}=10\text{ V}_{P-P}$, $V_{CC}=5.0\text{ V}$, $T_A=25^\circ\text{C}$

Parameter	Sym.	Min.	Typ.	Max.	Unit	Condition
CMTI at Logic High Level Output						
SFH6325	CM_H	—	1000	—	$\text{V}/\mu\text{s}$	$I_F=0\text{ mA}$, $R_L=4.1\text{ k}\Omega$
SFH6326						$I_F=0\text{ mA}$, $R_L=1.9\text{ k}\Omega$
CMTI at Logic Low Level Output						
SFH6325	CM_L	—	1000	—	$\text{V}/\mu\text{s}$	$I_F=16\text{ mA}$, $R_L=4.1\text{ k}\Omega$
SFH6326						$I_F=16\text{ mA}$, $R_L=1.9\text{ k}\Omega$

Figure 1. Switching Time and Test Circuit

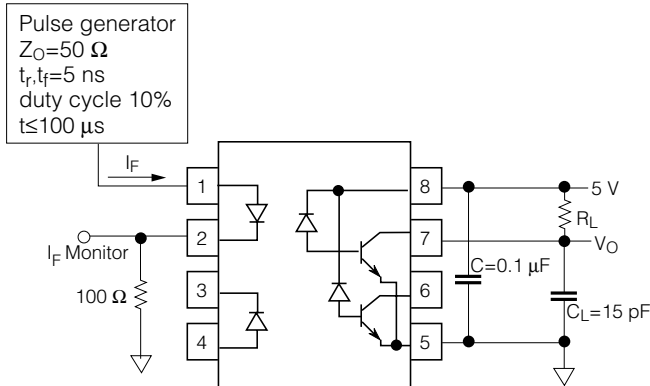
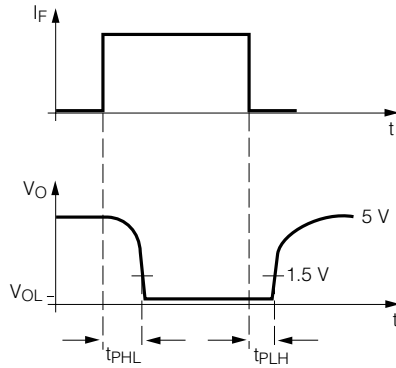


Figure 2. Waveform and Test Circuit for Common-Mode Transient Immunity

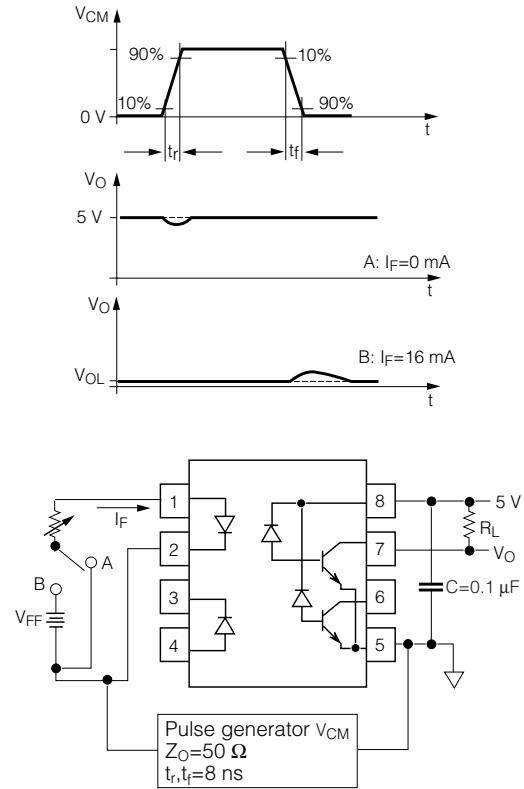


Figure 3. Forward Current vs. Forward Voltage $T_A=25^\circ\text{C}$

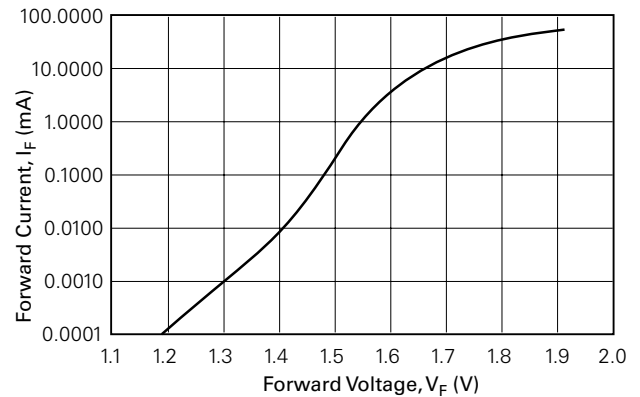


Figure 4. SFH6326 Collector Current vs. Forward Current at
 $V_{CC}=5.0\text{ V}$, $V_O=0.4\text{ V}$, $T_A=25^\circ\text{C}$

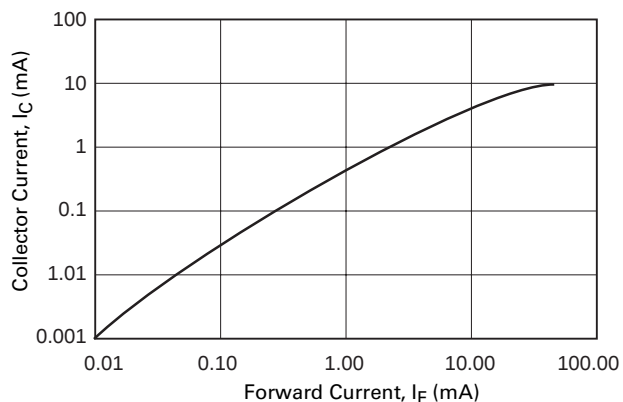


Figure 7. Output Current vs. Output Voltage
 $T_A=25^\circ\text{C}$, $V_{CC}=5.0\text{ V}$

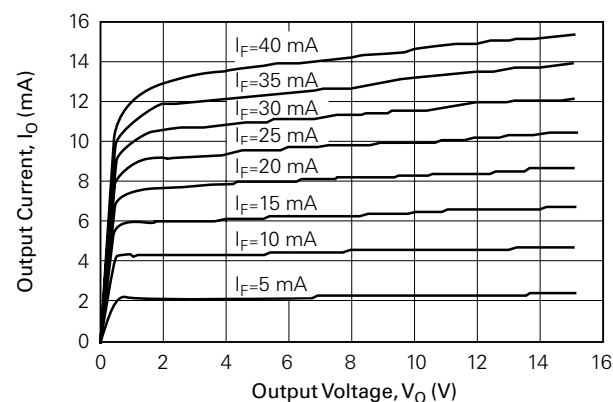


Figure 5. SFH6326 Current transfer ratio (normalized) vs. Forward Current

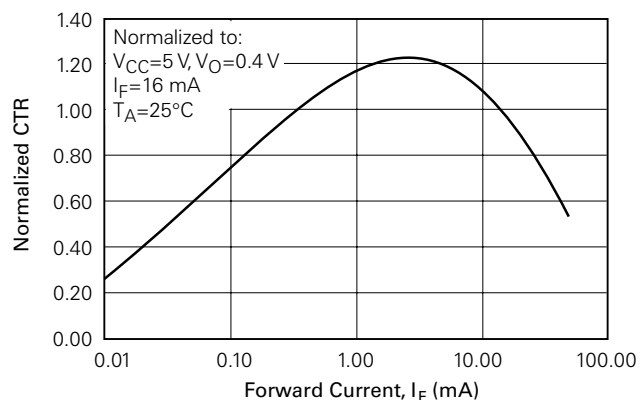


Figure 8. Output Current (high) vs. Ambient Temperature
 $I_F=0$

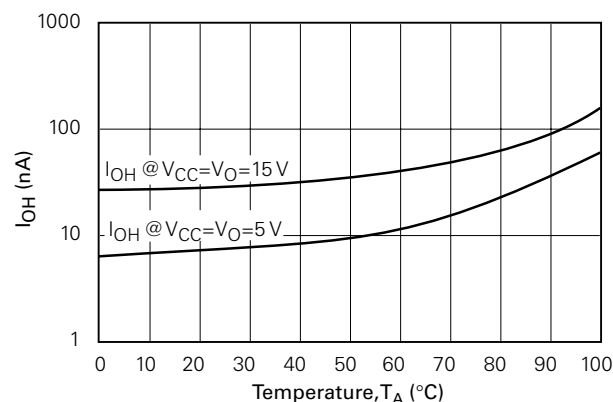


Figure 6. SFH6326 Current Transfer Ratio (normalized) vs. Ambient Temperature

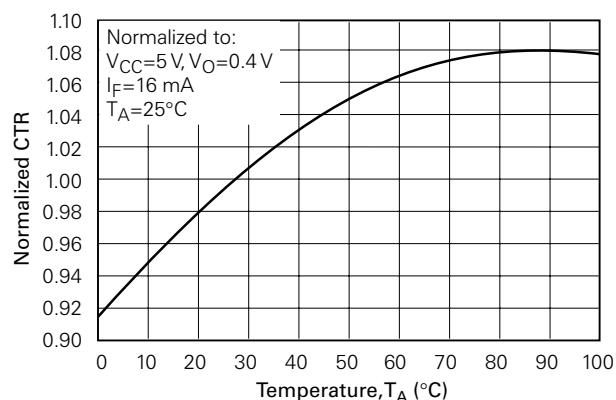


Figure 9. Output Current High Cross-talk (I_{OH-XT}) vs. Ambient Temperature

